

<b>Notice of References Cited</b>		Application/Control No. 10/758,660	Applicant(s)/Patent Under Reexamination FISCHER, JOHN G.	
		Examiner JAVID A. AMINI	Art Unit 2628	Page 1 of 1

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,721,832 A	02-1998	Westrope et al.	705/27
*	B	US-5,897,622 A	04-1999	Blinn et al.	705/26
*	C	US-5,918,217 A	06-1999	Maggioncalda et al.	705/36R
*	D	US-5,970,471 A	10-1999	Hill, Charles E.	705/26
*	E	US-2002/0041284 A1	04-2002	Konishi et al.	345/473
*	F	US-6,417,855 B1	07-2002	Yonts, Richard	345/473
*	G	US-2003/0103070 A1	06-2003	Tiongson et al.	345/700
*	H	US-7,027,055 B2	04-2006	Anderson et al.	345/473
*	I	US-7,035,919 B1	04-2006	Lee et al.	709/223
	J	US-			
	K	US-			
	L	US-			
	M	US-			

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Juha Savolainen, Juha Kuusela; Volatility analysis framework for product lines; ACM SIGSOFT Software Engineering Notes, Volume 26 Issue 3,
	V	A Multilevel Approach to Intelligent Information Filtering: Model, System, and Evaluation J. MOSTAFA Indiana University S. MUKHOPADHYAY Purdue University W. LAM The Chinese University of Hong Kong and M. PALAKAL Purdue University, 1997 ACM.
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.